

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LLOYD, JEFFREY	
		Examiner Devon C Kramer	Art Unit 3683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0173723 A1	09-2003	Behmenburg et al.	267/122
	B	US-2,960,333	11-1960	MCGAVERN JR SANFORD A; et. al.	267/64.24
	C	US-3,010,715	11-1961	BORDENKIRCHER BRUCE O; et. al.	267/64.24
	D	US-4,325,541	04-1982	Korosladanyi et al.	267/220
	E	US-4,877,223	10-1989	Hackett, Jeffrey K.	267/64.17
	F	US-4,741,517	05-1988	Warmuth et al.	267/64.24
	G	US-6,536,749 B1	03-2003	Luhmann et al.	267/64.19
	H	US-6,386,525 B1	05-2002	Stuart, John W.	267/64.27
	I	US-6,604,734 B1	08-2003	Griffiths, Paul J.	267/64.14
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004156663	06-2004	Japan	Namito et al	
	O	EP1429045	12-2002	Europe	Branco et al	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.